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# Structural Characterization of Tungsten Oxides Supported on Titanium Silicalite

Didik Prasetyoko<sup>1</sup>, Zainab Ramli<sup>2</sup>, Salasiah Endud<sup>2</sup> and Hadi Nur<sup>3</sup>

Abstract—Titanium silicalite (TS-1) is known as an active material catalyst in the epoxidation reaction. In this study, tungsten oxides (WO<sub>3</sub>) with various loading amount have been supported on the TS-1 to increase of the catalytic activity of the TS-1 material. The solids structure and property were investigated by X-ray diffraction (XRD), temperature programmed reduction (TPR), ultra violet-visible diffuse reflectance (UV-Vis-DR) and infrared (IR) spectroscopy and scanning electron microscopy (SEM) techniques. The results showed that the structure of TS-1 is not collapsed after impregnation of WO<sub>3</sub>. It was also found that tungsten species have interacted with the silanol groups on the surface of TS-1.

*Keywords*—Material catalysts, titanium silicalite, tungsten oxides, characterization

# I. INTRODUCTION

**C** ince Enichem has discovered the titanosilicate-1 [1], D many research groups have explored the structure, property and catalytic activity of the titanium-containing materials. It was due to the excellent activity and selectivity of TS-1 as catalysts in the various reactions such as amoximation, hydroxylation, and oxidation [1], [2], [3]. In the epoxidation reaction, the interaction between titanium and oxidizing agents to form titanium-oxo species is well known as the key step in the determination of the rate of reaction [4]. The development of the Ti-containing molecular-sieves catalysts in order to increase its catalytic activity towards epoxides is still in progress. Fierro and co-workers have reported the effect of alkali addition to the TS-1 catalyst. They observed that the selectivity of epoxide increased as the ratio of Lewis to Brønsted acid sites increased. We have reported the catalytic performance of modified TS-1 by impregnation of niobium oxide hydrated and sulfated zirconia [5]. It was proposed that the rate of the formation of epoxide was observed to increase in the modified TS-1 catalysts containing Brønsted acid sites, due to faster formation of reactive titanium-oxo intermediate.

Tungsten oxide-zirconia catalysts with loading amount higher than monolayer capacity showed both Brønsted and Lewis acid sites [6], [7], [8]. The high acid strength and high acidity were responsible for the W=O bond

<sup>1</sup> Didik Prasetyoko is with department of chemistry, FMIPA, Institut Teknologi Sepuluh Nopember, Surabaya, INDONESIA (email: dramadhani@yahoo.com) nature of complex formed by the interaction between  $WO_3$  and  $ZrO_2$  [9]. Generally, the structures and properties of supported metal oxide materials are strongly influenced by the metal oxide precursor, the loading amount of the metal oxide, the nature of support, and the experimental conditions. In this paper, catalysts  $WO_3/TS-1$ were prepared by impregnation of  $WO_3$  on the TS-1. The interaction of TS-1 and tungsten in the catalyst were examined by XRD, TPR, UV-Vis-DR, IR and SEM techniques.

#### II. EXPERIMENTAL

## A. Sample Preparation

The support, titanium silicalite (TS-1, 3 mol% titanium) was prepared according to a procedure described earlier [1]. The WO<sub>x</sub>/TS-1 catalysts were prepared by incipient wetness impregnation of TS-1 with an aqueous solution containing sufficient amount of ammonium metatungstate hydrate (NH<sub>4</sub>)<sub>6</sub> H<sub>2</sub>W<sub>12</sub>O<sub>41</sub>. 18H<sub>2</sub>O, to yield materials with loading in the ranges of 2–25 wt% of WO<sub>3</sub> in the calcined state. The suspension was heated at 110°C for 3 h under stirring condition, followed by evaporation of water, drying at 110°C for 24 h, and calcination at 550°C for 6 h. The samples denoted by their weight percentage of WO<sub>3</sub> on TS-1 (Table 1).

 $TABLE \ 1 \\ Amount \ of \ WO_3 \ loading \ of \ the \ samples \ using \ neutral \ preparation \ conditions$ 

Sample	WO <sub>3</sub> , wt%
TS-1	0
2WO <sub>3</sub> /TS-1	2.4
5WO <sub>3</sub> /TS-1	4.9
7WO <sub>3</sub> /TS-1	7.2
10WO <sub>3</sub> /TS-1	9.7
15WO <sub>3</sub> /TS-1	14.6
25WO <sub>3</sub> /TS-1	24.9

#### B. Characterization

The samples were characterized by powder X-ray diffraction (XRD) for the crystallinity and phase content of the solid materials using a Bruker Advance D8 Difractometer with the Cu K $\alpha$  ( $\lambda$ =1.5405 Å) radiation as the diffracted monochromatic beam at 40 kV and 40 mA. The pattern was scanned in the 2 $\theta$  ranges from 5° to 50° at a step size 0.010° and step time 1s. The reducibility of the surface species was determined by temperature-programmed reduction (TPR) of the samples using a TPDRO 1100 Thermofinnigan apparatus equipped with a thermal

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conductivity detector. The samples were calcined in static air at 550°C for 6 h before loaded in the quartz tube. The samples were pretreated in the stream of nitrogen with flow rate 40 ml/min (99.999%) at 100°C for 2 h. The reduction was performed with hydrogen in nitrogen (50 ml/min; 5% H<sub>2</sub> in N<sub>2</sub>) from 100°C to 1000°C with heating rate of 10°C and held at final temperature for 30 min. The hydroxyl groups of the samples were monitored by Fourier Transform Infrared (FTIR) spectroscopy technique. The wafer of the sample (10-12 mg) was locked in the cell equipped with CaF<sub>2</sub> windows, and evacuated at 400 °C under vacuum condition for 4 h. Infrared spectra of the sample were recorded at room temperature in the region of 4000 – 3000 cm<sup>-1</sup> on a Shimadzu FTIR, with a spectral resolution of 2 cm<sup>-1</sup>, scans 10 s, at temperature 20°C. UV-vis DR spectra were recorded under ambient conditions using a Perkin-Elmer Lambda 900 UV/VIS-/NIR spectrometer. The spectra were monitored in the range of 190-600 nm. Morphology of the TS-1 samples were monitored by SEM technique. Samples were poured on the stubs with double tape. Gold coating of the sample was performed by Bio Rad SEM Coating System at 10<sup>-1</sup> mbar with 30 mA for 75 minutes. Stubs containing sample was placed inside the electron microscope model Philip XL40 under vacuum at 5 bar. SEM micrograph was recorded with resolution of 30 kV.

## III. RESULT AND DISCUSSION

# A. X-ray Diffraction

The XRD patterns of the TS-1 and WO<sub>3</sub>/TS-1 samples with various tungsten loading and condition are shown in Fig. 1. The peaks corresponding to the crystalline phase of WO<sub>3</sub> at  $2\theta = 23.1$ , 23.7, 24.4, 33.2-34.6, and 41.5° (marks by arrow, in which the peaks at  $2\theta = 23-25^{\circ}$ overlapping with the peaks of TS-1) is only observed for the WO<sub>3</sub>/TS-1 samples with high amount of tungsten loading, ca. 10, 15 and 25wt%. The crystalline phase of WO<sub>3</sub> were not observed for the WO<sub>3</sub>/TS-1 samples with low loading amount of WO3, ca. 2, 5 and 7wt%. The result demonstrates that crystalline WO<sub>3</sub> appears only in samples with high loading while the WO<sub>3</sub> exists as highly dispersed species in the low loading samples. This finding is in a good agreement [10] in which the characteristic peaks of crystalline WO<sub>3</sub> were clearly seen for the samples with high loading amount of WO<sub>3</sub>, ca. >6% and 10%, depending on the nature of support.

Fig. 2 shows the correlation of the surface concentration of the tungsten vs. the ratio of the diffraction peak intensity of WO<sub>3</sub> to that of TS-1 ( $I_{WO3}/I_{TS-1}$ ; 20: 34.17° /23.04°) in various WO<sub>3</sub> loading. Based on this graph, the dispersion capacity of tungsten on the titanium silicalite support was evaluated to be 0.35 W<sup>6+</sup> cations/nm<sup>2</sup>, by extrapolating the straight line to get the intercept on the abscissa. For comparison, the dispersion capacity of the WO<sub>3</sub> on TiO<sub>2</sub> anatase by using similar characterization and technique was reported to be 4.85 W<sup>6+</sup>/nm<sup>2</sup> of TiO<sub>2</sub> [11], which comparable with dispersion capacity of the WO<sub>3</sub> on ceria, ca. 4.8 W<sup>6+</sup>/nm<sup>2</sup> (Dong *et al.*, 2000). While on silica support, the dispersion capacity of WO<sub>3</sub> was 0.5 W<sup>6+</sup>/nm<sup>2</sup> [10]. On TS-1 support, the dispersion capacity

of WO<sub>3</sub> is much lower than that of anatase and ceria supports, and near to the silica support, in which these supports have lower surface area (below 300 m<sup>2</sup>/g). It seems to deduce that surface interaction between WO<sub>3</sub> with TS-1 is evidently different from that of WO<sub>3</sub> with anatase and ceria, but almost the same with WO<sub>3</sub> and silica. This might be due to the highly crystalline phase of TS-1, causes weak interaction of the support with the metal oxide, thus reducing the dispersion capacity of the supported metal oxides.

# B. Temperature Programmed Reduction

The reduction behavior of supported tungsten oxide on alumina and silica depends on the amount of the metal oxide on the support and the interaction of the metal oxide with the support [10]. Fig. 3 shows the TPR profiles of bulk WO<sub>3</sub> and the TS-1 containing various amount of tungsten oxide loading. The TPR profile of 5 mg sample of bulk WO<sub>3</sub> exhibits two very high intense peaks of hydrogen consumed beginning at 600°C and centered at 805 and 865°C. These peaks can be assigned to the step-wise reduction of WO<sub>3</sub> to W, i.e.  $W(VI) \rightarrow W(IV)$  $\rightarrow$  W(0) [12]. The TPR profiles of samples WO<sub>3</sub>/TS-1 generally show similar reduction temperature, i.e. a broad reduction peak from around 400°C to 600°C and two high intense reduction peaks centered at around 750 and 800°C. According to reference [13], [14], the broad peak is assigned to octahedrally coordinated tungsten species. It was found that the amount of hydrogen consumed corresponding to this peak increased as the amount of WO<sub>3</sub> loading increased, indicating that the concentration of octahedral species in the samples is increased. On the other hand, the high intense peak at around 800°C is attributed to the  $W^{6+} \rightarrow W^0$  reduction of tetrahedrally coordinated amorphous WO<sub>x</sub> species [14]. Yori [15] have reported on WO<sub>3</sub>/ZrO<sub>2</sub> system that octahedrally coordinated tungstate species requires lower reduction temperature than of tetrahedral tungstate species. In this study, the reduction temperatures at around 800°C of the samples were found to shift to higher temperatures depending on the amount of WO<sub>3</sub> loadings. In addition, the hydrogen consumption increased with the increasing amount of WO<sub>3</sub> loading. This finding suggests that the amount of tetrahedral tungsten species increases as the tungsten loading increases.

Furthermore, a small peak at around 500°C is observed on samples with WO<sub>3</sub> loading higher than the monolayer dispersion, i.e.  $7WO_3/TS-1$ ,  $10WO_3/TS-1$ ,  $15WO_3/TS-1$ and  $25WO_3/TS-1$  samples. On the basis of XPS and XRD results for WO<sub>3</sub>/ $\alpha$ -Al<sub>2</sub>O<sub>3</sub>, [16] assigned the peak at 500°C was the reduction of WO<sub>3</sub> crystallite on top of the monolayer. In this analysis, the dispersion capacity of WO<sub>3</sub> calculated based on the XRD result was found to be higher than the monolayer of WO<sub>3</sub>.

In addition, it is obtained that the amount of hydrogen consumed increased as the amount of WO<sub>3</sub> in the samples increased. However, similar amount of WO<sub>3</sub> containing in the bulk WO<sub>3</sub> and sample 25WO<sub>3</sub>/TS-1 resulted in the different amount of hydrogen consumed. Although reference [16] have shown that WO<sub>3</sub> in the WO<sub>3</sub>/ $\alpha$ -Al<sub>2</sub>O<sub>3</sub> cannot be reduced in one step reduction processes, here,

it is found that the amount of hydrogen consumed in the bulk  $WO_3$  has three times higher compared to sample  $25WO_3/TS-1$ . This finding indicates that there are interactions between tungstate and TS-1 support in the sample  $WO_3/TS-1$ .

# C. UV-Vis. DR Spectroscopy

The structures of tungsten oxide on the surface of TS-1 have been characterized by UV-Vis DR spectroscopy technique. Generally, there are two types of tungsten oxides based on the geometry, i.e. octahedral ( $O_h$ ) and tetrahedral ( $T_d$ ) structures. In the UV-Vis DR spectra, the bands corresponding to tetrahedral and octahedral tungsten species appear in the spectral range of 220 – 375 nm. In the UV-Vis DR spectra, the charge transfer transmission O<sup>2-</sup>  $\rightarrow$  W<sup>6+</sup> is blue-shifted from around 375 nm for the pure oxide which contains tungsten in octahedral coordination to 220 nm for the pure Na<sub>2</sub>WO<sub>4</sub>.2H<sub>2</sub>O which contains tetrahedral WO<sub>4</sub><sup>2-</sup> ions [17].

The UV-Vis DR spectra of the samples WO<sub>3</sub>/TS-1 containing various amounts of tungsten loading and bulk WO<sub>3</sub> samples are given in Fig. 4. Sample TS-1 only shows a single band at around 210 nm characteristic of tetrahedral titanium structure. The spectrum of bulk WO<sub>3</sub> shows a high broad band and two shoulder bands at around 370, 265 and 220 nm, respectively. The first two bands are assigned to octahedral WO<sub>3</sub> crystallites and polyoxotungstate species, while the latter band is assigned to tetrahedral tungsten species [12], [18]. The results confirm that bulk WO<sub>3</sub> contains mostly octahedral tungsten species.

For samples WO<sub>3</sub>/TS-1, all the samples show similar bands centered in the range of 215–235 nm, which according to [12] are attributed to tetrahedrally coordinated W(VI) species. In addition, the band for octahedral polyoxotungstate W(VI) species at around 265 nm is not observed. Moreover, the intensity of the band at around 220 nm is increases as the loading amount of tungsten increases, in which sample  $25WO_3/TS-1$  shows the highest intensity among the samples. The increasing intensity of the band at 220 nm suggests that the amount of tetrahedral tungsten is also increased.

## D. Infrared Spectroscopy of Hydroxyl Groups

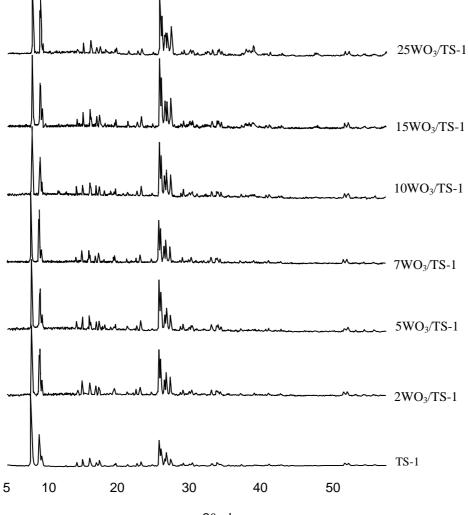
The infrared spectra of the TS-1 and WO<sub>3</sub>/TS-1 samples were recorded in the range of hydroxyl stretching region at 4000  $-3000 \text{ cm}^{-1}$ . The infrared spectra of all samples are shown in Fig. 5. The noise of the spectra is very high for sample with high tungsten loading, ca. >10wt% renders any other hydroxyls vibration to be detected in this region. After evacuation in vacuum at 400°C for 4 h, the parent support, TS-1 sample shows an

intense band at 3726 cm<sup>-1</sup> and a broad band centered at 3505 cm<sup>-1</sup>. A shoulder band also can be detected between those two bands, centered at 3680 cm<sup>-1</sup>. The higher frequency intense band at 3726 cm<sup>-1</sup> is characteristics for silanol hydroxyl groups. However, the frequency of this band is slightly lowers with respect to the typical silanol of amorphous silica (3741 cm<sup>-1</sup>) [19]. The broad band at 3505 cm<sup>-1</sup> associated to hydroxyl groups with hydrogen bonding of water molecule with silanol groups [19]. The last band (3680 cm<sup>-1</sup>) has been assigned by Zecchina [20] to different structure of terminal hydroxyl groups in the zeolitic pores.

After deposition of tungsten in the TS-1 sample, the hydroxyl region of the spectrum changed as can be seen in Fig. 5. The band position of TS-1 sample at 3726 cm<sup>-1</sup> does not shift to lower or higher frequency. However, this band becomes slightly broader with lower intensity compare to the TS-1 sample, were observed for the lower WO<sub>3</sub> loading, as in the 2WO<sub>3</sub>/TS-1, 5WO<sub>3</sub>/TS-1 and 7WO<sub>3</sub>/TS-1 samples. Similar phenomenon also appeared for a broad band at around 3505 cm<sup>-1</sup>, although only observed for 2WO<sub>3</sub>/TS-1 and 5WO<sub>3</sub>/TS-1 samples. For samples with high WO<sub>3</sub> loading, as in the 10WO<sub>3</sub>/TS-1, 15WO<sub>3</sub>/TS-1 and 25WO<sub>3</sub>/TS-1 samples, the isolated silanol peak is not displayed, while the peak for hydroxyl groups with hydrogen bonding started to disappear for 7WO<sub>3</sub>/TS-1 sample. These observation shows that both of the hydroxyl groups of TS-1 (hydroxyl silanol and hydroxyl hydrogen bonding) are involved in the reaction with tungsten, in which the hydroxyl groups with hydrogen bonding is more reactive than that of silanol groups. In the previous study, Wang [10] found that only silanol groups involved in the reaction with tungsten.

### E. Scanning Electron Microscope

Samples morphology were monitored using electron microscope. Fig. 6 shows the SEM images of TS-1 and WO<sub>3</sub>/TS-1 materials. The SEM image shows that TS-1 has two morphology, i.e. single and twinned crystal shape. The crystal size around 0.2-0.8 x 0.5-1 x 1-2.5, in which twinned shape has larger crystals size than single shape. The morphology of TS-1 is not affected by impregnation of 5 wt% tungsten oxide on the surface of TS-1. Similar with the XRD technique, SEM cannot monitor the evident of tungsten oxide in the sample 5WO<sub>3</sub>/TS-1. This finding indicated the high dispersion of tungsten on the surface of TS-1. Meanwhile, a grubby TS-1 crystal is observed in the sample 25WO<sub>3</sub>/TS-1. Based on the XRD finding, this sample contained tungsten oxide crystal. Therefore, it is concluded that a small particle observed on the surface of TS-1 is tungsten oxide. However, the morfology of TS-1 is not affected by impregnation of tungsten oxides.



 $2\theta$ , degree

Fig. 1: XRD patterns of the TS-1 and tungsten-coated TS-1 samples

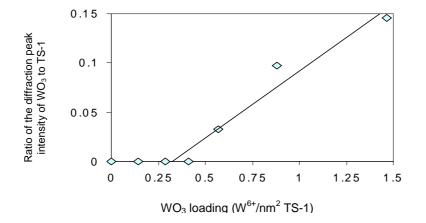
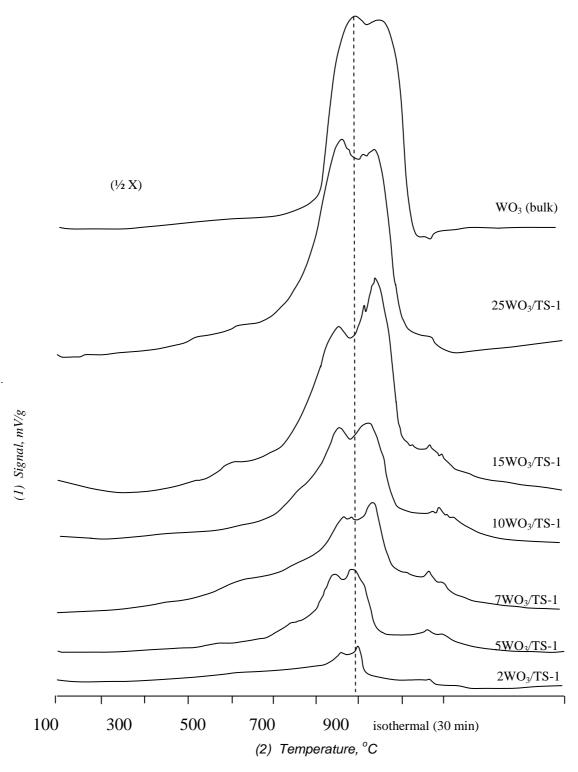
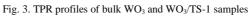


Fig. 2: The WO<sub>3</sub> content vs. XRD peak intensity ratio of WO<sub>3</sub> to TS-1 in the samples





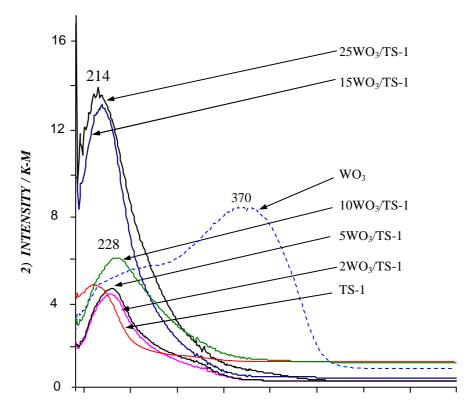


Fig. 4. UV-Visible DR spectra of TS-1, WO<sub>3</sub>, and WO<sub>3</sub>/TS-1 samples.

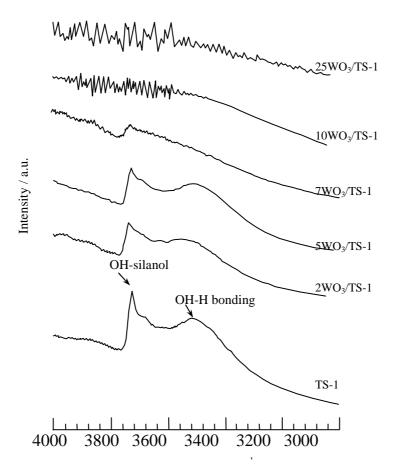


Fig. 5. Infrared spectra in the range of hydroxyl groups observation for titanium silicalite samples with different WO<sub>3</sub> content.

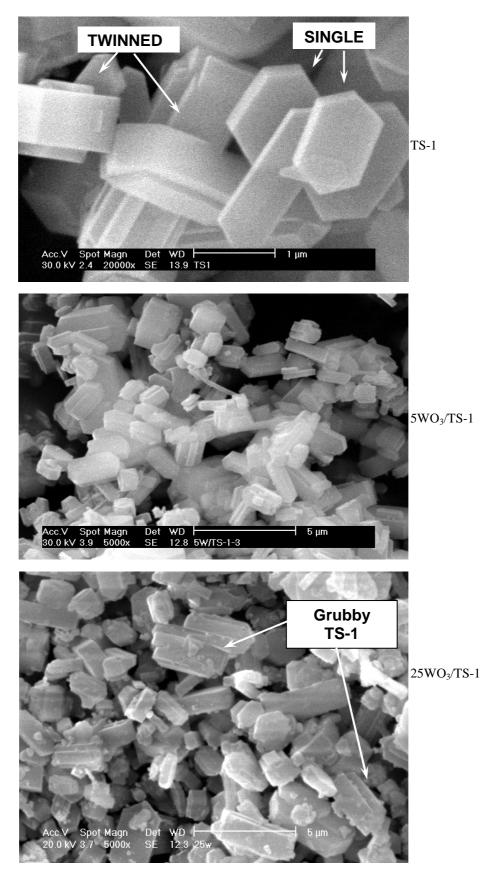


Fig. 6. The SEM images of the TS-1 materials

## IV. CONCLUSIONS

The crystal structure and morphology of TS-1 is not affected by impregnation of tungsten oxides. The tungsten in the WO<sub>3</sub>/TS-1 material existed in the tetrahedral coordination. It was found that the surface silanol groups of TS-1 have interacted with the tungsten oxides. However, tungsten oxide exists in a bulk WO<sub>3</sub> at high amount of tungsten loading. Therefore, it was suggested the formation of Si-O-W bond in the WO<sub>3</sub>/TS-1 catalysts.

# V. ACKNOWLEDGMENT

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